

Search Notes

Application/Control No.

10/800,679

Examiner

Y. J. Han

Applicant(s)/Patent under
Reexamination

IMAI ET AL.

Art Unit

2838

SEARCHED

Class	Subclass	Date	Examiner
323	222		
	225		
	273		
	274		
	282		
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	284		
	299		
	351	4/6/2006	/JH/

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
See search report		4/17/2006	/JH/

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR